Substitute Form PTO-1449
(Modified)U.S. Department of Commerce
Patent and Trademark OfficeAttorney's Docket No.
10449-033001Application No.
09/748,400**Information Disclosure Statement
by Applicant**

(Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant
Koji Hayashi et al.Filing Date
December 26, 2000Group Art Unit
2615-2653**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
GC	AD	6,775,211 B1	08-2004	Tsukihashi	369	47.28	/
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

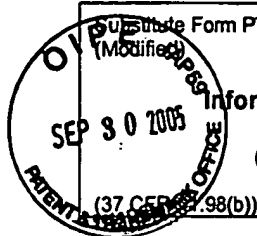
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	AQ	
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11/16/05

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		Applicant Koji Hayashi et al.	
		Filing Date December 26, 2000	Group Art Unit 2015 2653

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>ku</i>	AA	4,860,272	08/1989	Nishikawa et al.	<i>369</i>	<i>53.28</i>	<i>—</i>
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*677521***Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AE							
	AF							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AG	
	AH	

Examiner Signature <i>Kim Chun</i>	Date Considered <i>11/16/05</i>
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